The Importance of Sulfur Host Structural Preservation for Lithium–Sulfur Battery Performance

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Fig. S1. Low magnification SEM images of (a) CIO-100, (b) CIO-200, (c) CIO-500 and (d) CIO-1000



Fig. S2. Low magnification SEM images of an S-infilled CIO-200 sample

Fig. S3. Tilted SEM images of a fractured S-infilled CIO-200 sample, demonstrating the thickness of the IO material. (Tilt angle: 90°)

Fig. S4. Areal charge values for sulfur infilled CIO-100, CIO-200, CIO-500 and CIO-1000 over 250 cycles. All samples were cycled in a potential window of 2.7 - 1.8 V (vs Li/Li⁺) at 0.2 C.

Fig. S5. A range of galvanostatic discharge and charge curves for (a) CIO-100, (b) CIO-200, (c) CIO-500 and (d) CIO-1000. All samples were cycled at a rate of 0.2 C. The cycles shown are for the 1^{st} , 2^{nd} , 5^{th} , 10^{th} and 25^{th} cycles and then every 25^{th} cycle from the 25^{th} to the 250^{th} cycle.

Fig. S6: Deconvoluted cyclic voltammogram for an S-infilled CIO-100 sample

Fig. S7. Comparison of specific charge values obtained for an S-infilled carbon IO and a carbon IO slurry in this study with previously reported values for other carbon IO S-hosts. ¹⁻³

Fig. S8. SEM images of a carbon IO prepared with 500 nm diameter PSS after being removed from a stainless steel substrate and being ground in a mortar and pestle.

Fig. S9. A comparison of voltage profiles obtained for (a) the 1^{st} and (b) the 250^{th} cycles for a CIO-200-Slurry electrode, a binder/conductive additive free CIO-200 sample and a conventional C/S slurry. Comparison of (c) the specific capacity retention and (d) the Coulombic efficiency over 250 cycles. All samples were cycled in a potential window of 2.7 - 1.8 V (vs Li⁺/Li) at 0.2 C.

Fig. S10. (a) Radar plot comparing the FWHM of the D-band, from analysis of Raman spectroscopy, specific charge and Coulombic efficiency values for sulfur infilled CIO-100, CIO-200, CIO-500 and CIO-1000. (b) Radar plot comparing the electrochemical performance of CIO-200, CIO-200-Slurry and a conventional S/C composite slurry. Legend: S.C. = specific capacity, C. E. = Coulombic efficiency, D = Discharge.

References

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